

INFORMATION DESCRIPTION OF STATEMENT PTO Form 1449

Docket Number Serial Number 1202.014US1 09/899,503 Applicant(s) Mikhail Trifonov, et al. Group Art Unit 2621 Filing Date July 5, 2001

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INITIALS	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE (IF APPROPRIATE)
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Date Considered: Examiner:

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INFORMATION DISCLOSURE STATEMENT

Docket Number 1202.014US1 Serial Number 09/899,503 Applicant(s) Mikhail Trifonov, et al.

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Group Art Unit 2621

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EXAMINER INITIALS	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE (IF APPROPRIATE)

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				(5.55	300-0433	YES	NO
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